

# MP4209

High Power, High Speed Switching Applications  
 For Printer Head Pin Driver and Pulse Motor Driver  
 For Solenoid Driver

- 4-V gate drivability
- Small package by full molding (SIP 10 pins)
- High drain power dissipation (4-device operation)  
 :  $P_T = 4 \text{ W}$  ( $T_a = 25^\circ\text{C}$ )
- Low drain-source ON resistance:  $R_{DS(ON)} = 0.28 \Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 3.5 \text{ S}$  (typ.)
- Low leakage current:  $I_{GSS} = \pm 10 \mu\text{A}$  (max) ( $V_{GS} = \pm 16 \text{ V}$ )  
 $I_{DSS} = 100 \mu\text{A}$  (max) ( $V_{DS} = 100 \text{ V}$ )
- Enhancement-mode:  $V_{th} = 0.8 \text{ to } 2.0 \text{ V}$  ( $V_{DS} = 10 \text{ V}$ ,  $I_D = 1 \text{ mA}$ )

### Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Characteristics		Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	100	V
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		$V_{DGR}$	100	V
Gate-source voltage		$V_{GSS}$	$\pm 20$	V
Drain current	DC	$I_D$	3	A
	Pulse	$I_{DP}$	12	
Drain power dissipation (1-device operation, $T_a = 25^\circ\text{C}$ )		$P_D$	2.0	W
Drain power dissipation (4device operation, $T_a = 25^\circ\text{C}$ )		$P_{DT}$	4.0	W
Single pulse avalanche energy (Note 1)		$E_{AS}$	140	mJ
Avalanche current		$I_{AR}$	3	A
Repetitive avalanche energy (Note 2)	- device operation	$E_{AR}$	0.2	mJ
	4device operation	$E_{ART}$	0.4	
Channel temperature		$T_{ch}$	150	$^\circ\text{C}$
Storage temperature range		$T_{stg}$	-55 to 150	$^\circ\text{C}$

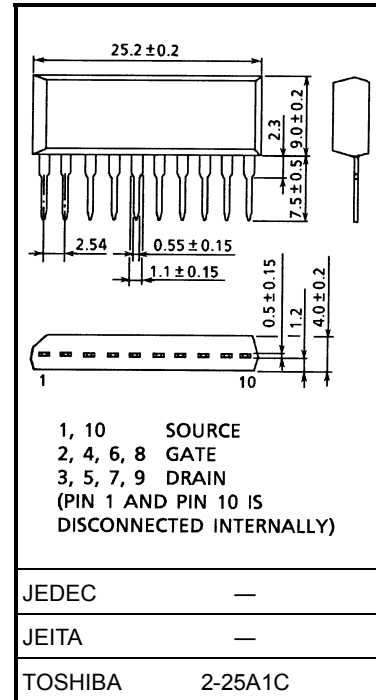
Note 1: Condition for avalanche energy (single pulse) measurement  
 $V_{DD} = 50 \text{ V}$ , starting  $T_{ch} = 25^\circ\text{C}$ ,  $L = 20 \text{ mH}$ ,  $R_G = 25 \Omega$ ,  $I_{AR} = 3 \text{ A}$

Note 2: Repetitive rating; pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

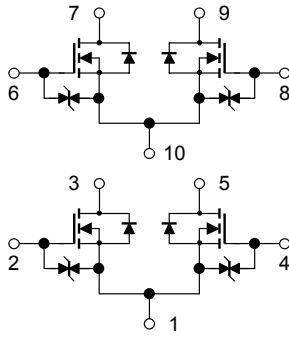
Industrial Applications

Unit: mm



Weight: 2.1 g (typ.)

## Array Configuration



## Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance from channel to ambient (4-device operation, $T_a = 25^\circ\text{C}$ )	$\Sigma R_{\text{th (ch-a)}}$	31.2	$^\circ\text{C/W}$
Maximum lead temperature for soldering purposes (3.2 mm from case for $t = 10$ s)	$T_L$	260	$^\circ\text{C}$

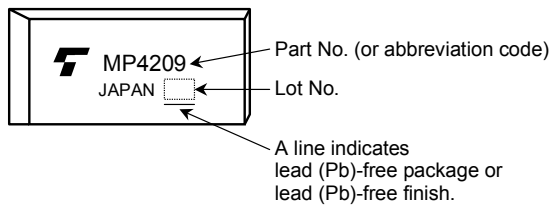
## Electrical Characteristics ( $T_a = 25^\circ\text{C}$ )

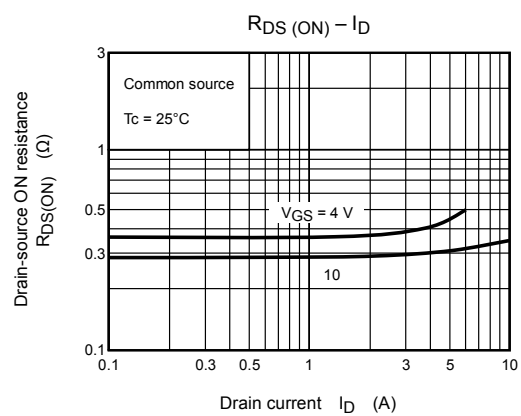
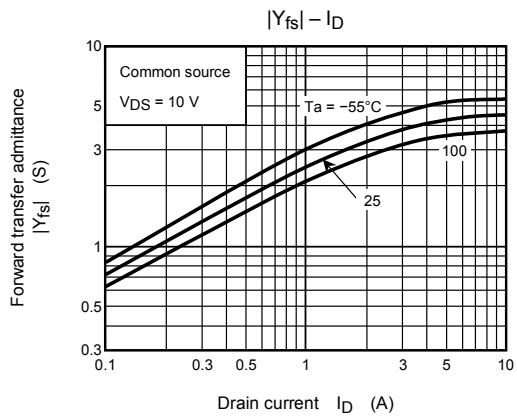
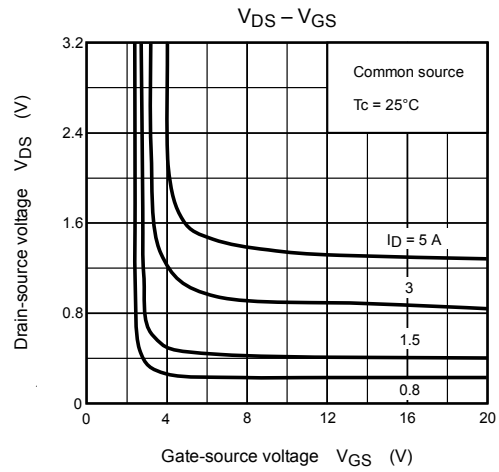
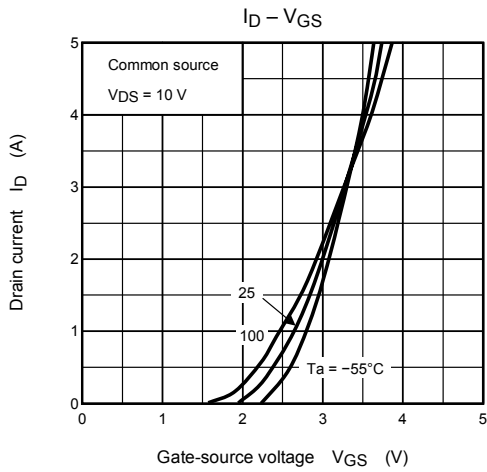
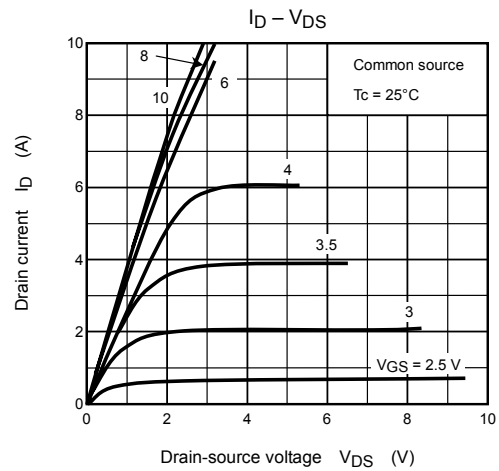
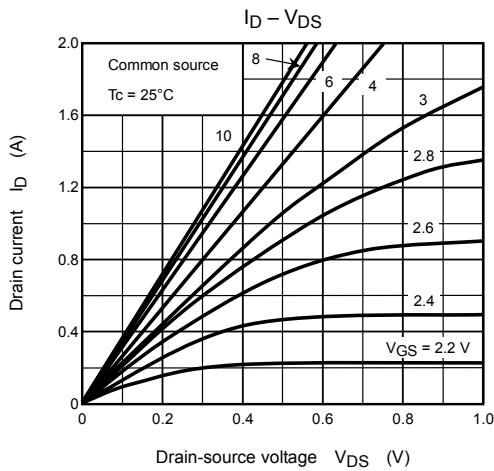
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		$I_{\text{GSS}}$	$V_{\text{GS}} = \pm 16 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	—	—	$\pm 10$	$\mu\text{A}$
Drain cut-off current		$I_{\text{DSS}}$	$V_{\text{DS}} = 100 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	—	—	100	$\mu\text{A}$
Drain-source breakdown voltage		$V_{(\text{BR})\text{DSS}}$	$I_{\text{D}} = 10 \text{ mA}, V_{\text{GS}} = 0 \text{ V}$	100	—	—	V
Gate threshold voltage		$V_{\text{th}}$	$V_{\text{DS}} = 10 \text{ V}, I_{\text{D}} = 1 \text{ mA}$	0.8	—	2.0	V
Drain-source ON resistance		$R_{\text{DS (ON)}}$	$V_{\text{GS}} = 4 \text{ V}, I_{\text{D}} = 2 \text{ A}$	—	0.36	0.45	$\Omega$
			$V_{\text{GS}} = 10 \text{ V}, I_{\text{D}} = 2 \text{ A}$	—	0.28	0.35	
Forward transfer admittance		$ Y_{\text{fs}} $	$V_{\text{DS}} = 10 \text{ V}, I_{\text{D}} = 2 \text{ A}$	1.5	3.5	—	S
Input capacitance		$C_{\text{iss}}$	$V_{\text{DS}} = 10 \text{ V}, V_{\text{GS}} = 0 \text{ V}$ $f = 1 \text{ MHz}$	—	280	—	pF
Reverse transfer capacitance		$C_{\text{rss}}$		—	50	—	
Output capacitance		$C_{\text{oss}}$		—	105	—	
Switching time	Rise time	$t_r$		—	20	—	ns
	Turn-on time	$t_{\text{on}}$		—	50	—	
	Fall time	$t_f$		—	40	—	
	Turn-off time	$t_{\text{off}}$		—	170	—	
Total gate charge (gate-source plus gate-drain)		$Q_g$	$V_{\text{DD}} \approx 80 \text{ V}, V_{\text{GS}} = 10 \text{ V}$	—	13.5	—	nC
Gate-source charge		$Q_{\text{gs}}$	$I_{\text{D}} = 3 \text{ A}$	—	8.5	—	nC
Gate-drain ("miller") charge		$Q_{\text{gd}}$		—	5	—	nC

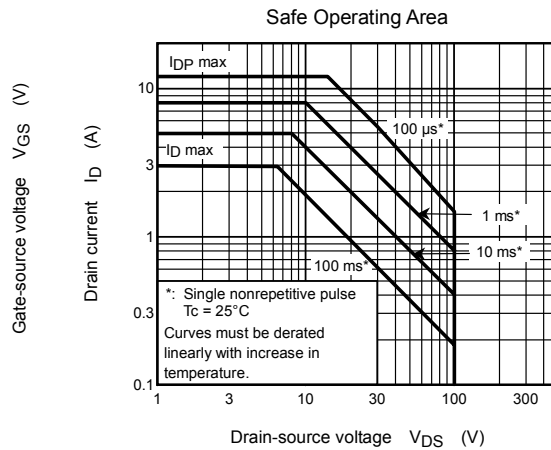
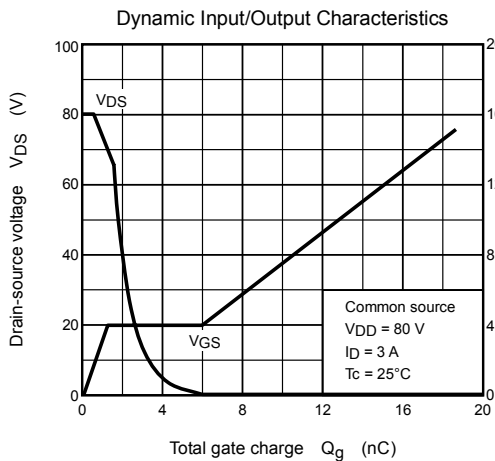
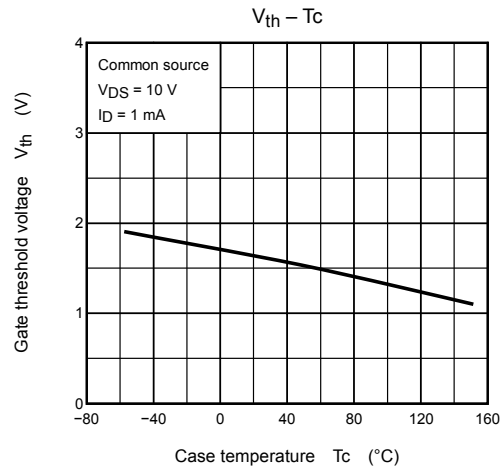
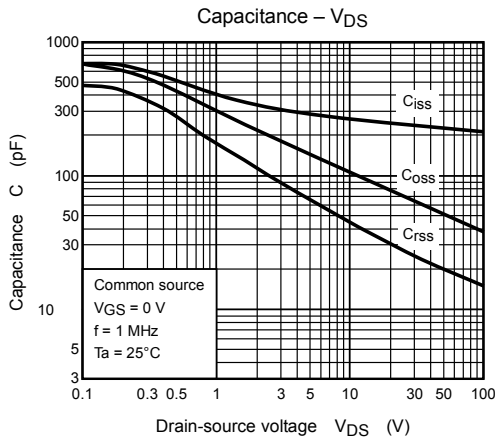
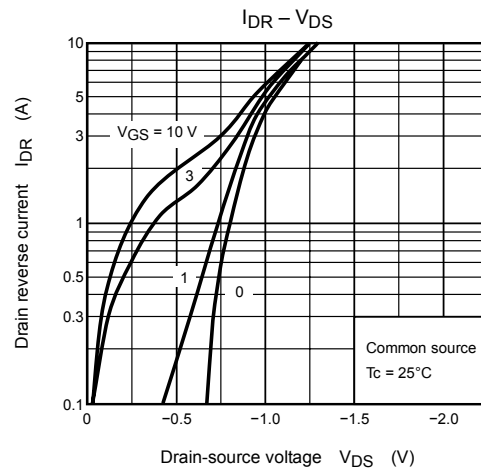
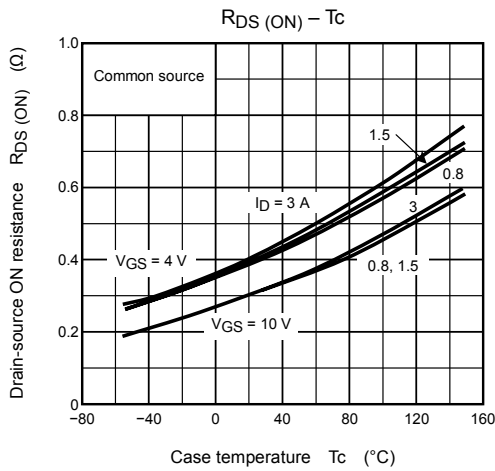
## Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

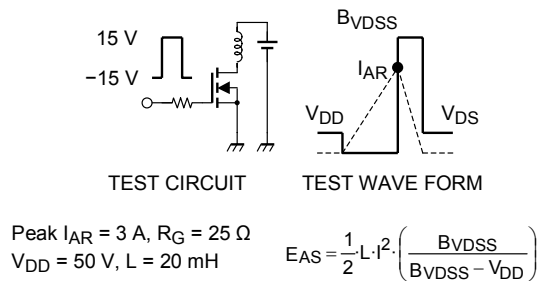
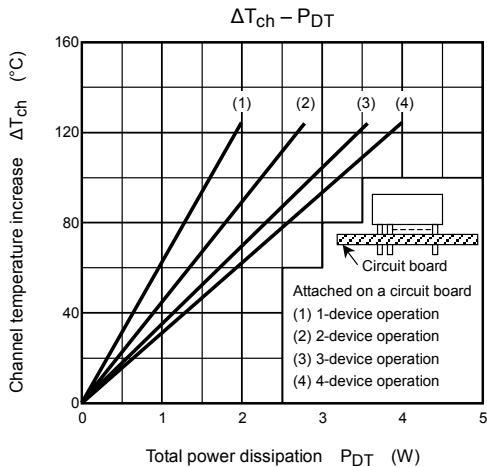
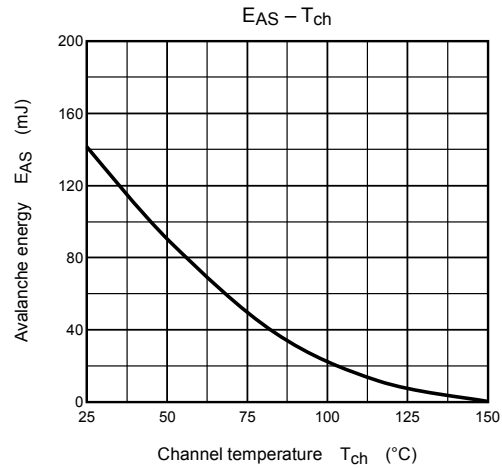
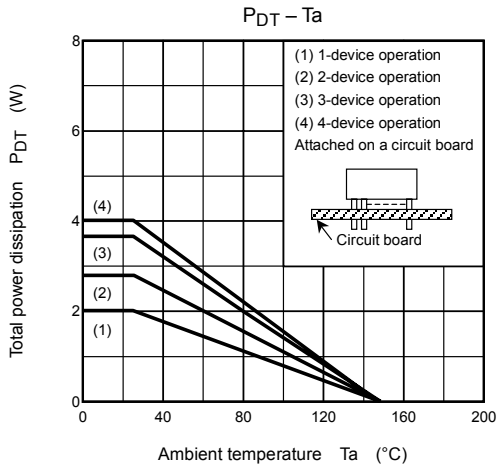
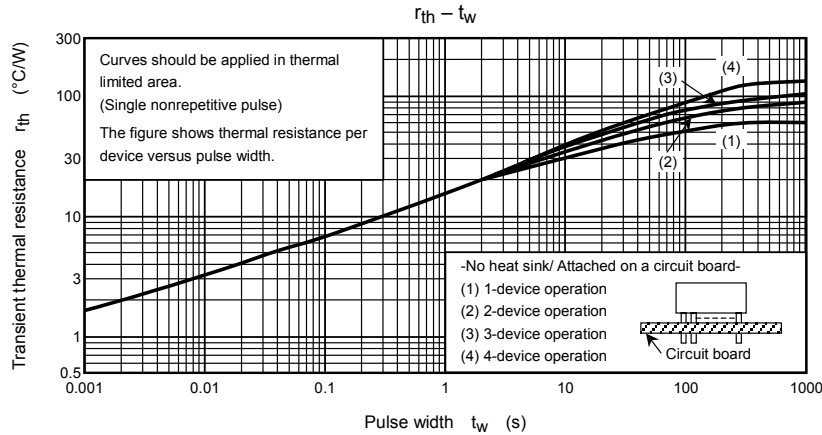
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current	$I_{DR}$	—	—	—	3	A
Pulse drain reverse current	$I_{DRP}$	—	—	—	12	A
Diode forward voltage	$V_{DSF}$	$I_{DR} = 3\text{ A}, V_{GS} = 0\text{ V}$	—	—	-1.5	V
Reverse recovery time	$t_{rr}$	$I_{DR} = 3\text{ A}, V_{GS} = 0\text{ V}$	—	100	—	ns
Reverse recovery charge	$Q_{rr}$	$dI_{DR}/dt = 50\text{ A}/\mu\text{s}$	—	0.2	—	$\mu\text{C}$

## Marking









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